

# INVITATION TO EXHIBIT

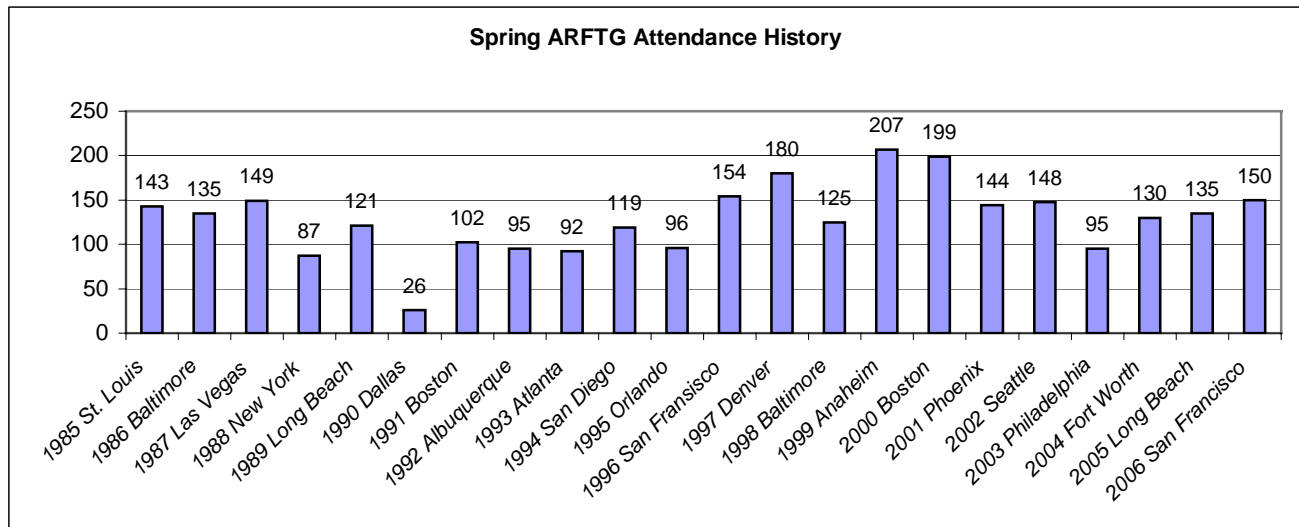
## 69th ARFTG CONFERENCE IEEE MTT-S IMS2007, Honolulu, Hawaii June 8th, 2007

In conjunction with Microwave Week 2007, the Automatic RF Techniques Group will hold its 69th ARFTG Microwave Measurement Conference at the Hilton Hawaiian Village, Honolulu, Hawaii. The conference technical theme is “*Addressing Metrology Needs for Future High-Speed Information and Communication Systems*” and will also cover other aspects of microwave measurement.

During this conference there will be an exhibits area for the display of microwave measurement equipment, simulation tools, and associated products. On behalf of the Exhibits Committee I would like to extend an invitation to exhibit. This is an excellent opportunity to present your company’s latest products and techniques to an exceptionally qualified audience.

The exhibits area will be adjacent to the technical program hall, which will ensure exposure to all of the conference participants. This is a valuable opportunity to exhibit your products to a focused measurement community in the comfortable, personal atmosphere afforded by ARFTG.

The exhibitor application and rules document is attached. Please contact me if you have any questions about this opportunity. I hope that you will join us in Honolulu!



Joe Tauritz, Chair  
ARFTG Exhibits Committee  
+31-70-5177398  
jltauritz@ieee.org

[www.arftg.org](http://www.arftg.org)